

<b>Notice of References Cited</b>	Application/Control No. 10/630,717	Applicant(s)/Patent Under Reexamination JUNG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0056868	03-2004	Kato, Fumihiko	345/600
	B	US-2003/0218591	11-2003	Shen et al.	345/89
	C	US-2003/0169248	09-2003	Kim et al.	345/204
	D	US-2002/0145598	10-2002	Shen et al.	345/209
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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